## **Evaluating the Work Quality of Optical Character Recognition Libraries**

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## key words

control and measuring instruments, measuring devices, machine learning, neural networks, quality, optical cameras The process of automation of verification of electrical control and measuring instruments implies the performance of instrumentation certification without full or partial participation of the operator, to a greater extent through the performance of operations by the instrumentation. With digital devices the speed of display and reproduction of the measured value is much higher than with analog-arrow devices, but in the case of automation and for devices without communication protocols with information systems the stage of fixation of values becomes much more complicated. The solution to this problem is the use of machine learning technology in the field of optical recognition. In this case, in the issue of recognition, recording and processing of results, the key parameters are speed, accuracy, complexity of adjustment and the proportion of recognized data. The purpose of this study is to study the existing technological methods of recognizing values from the screens of digital devices, evaluation and determination of the most optimal methods that provide the highest level of quality assurance automation of the process of verification of electrical control and measuring instruments.

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